## Agostic Interactions

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## Persistent Silylium Ions Stabilized by Polyagostic Si-H···Si Interactions\*\*

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Dedicated to Professor J. Lorberth on the occasion of his 70th birthday

Silylium ions are much more reactive than corresponding carbenium ions owing to the larger size of the silicon atom and their higher electrophilicity. In the absence of sufficient steric protection, silylium ions readily interact even with weakly nucleophilic molecules such as the perchlorate anion, halocarbons, halocarbons, alkenes, alkenes, alkenes, are sult, a genuine tricoordinate ("naked") silylium ion has been prepared only recently. More recently, Müller et al. have reported that formation of a 3c–2e bond (R<sub>3</sub>Si-H-SiR<sub>3</sub>) can stabilize a cationic silicon center (1 and 2) even in the absence of steric protection. A similar R<sub>3</sub>B···H-SiR<sub>3</sub> interaction (3), with a stronger H–Si bond and weaker B···H bonding, was described

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Supporting information for this article is available on the WWW under http://www.angewandte.org or from the author.

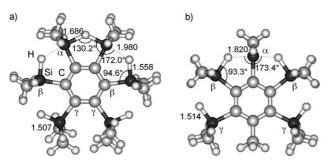
by Wrackmeyer et al.<sup>[14]</sup> Herein we report the case of polyagostic Si-H-Si interactions in a series of silylium ions derived from polysilyl-substituted benzenes.

Hydride abstraction<sup>[10a]</sup> from  $C_6(SiHMe_2)_6$  by  $[Ph_3C][B-(C_6F_5)_4]$  generates the silylium ion **4** quantitatively according to NMR spectra [Eq. (1)]. At -80 °C, the <sup>1</sup>H NMR spectrum

of 4 in  $CD_2Cl_2$  exhibits an effective  $C_{2\nu}$  structure with three broad SiH signals at  $\delta = 4.64$  ( $\gamma$ -SiH), 4.41 ( $\beta$ -SiH), and 4.26 ppm ( $\alpha$ -SiH) with relative intensities of 2:2:1 and three Me signals of equal intensity, at  $\delta = 0.88$  (α-SiMe), 0.67 (β-SiMe), and 0.49 ppm ( $\gamma$ -SiMe).<sup>[15]</sup> The upfield shift of the  $\alpha$ -SiH and β-SiH resonances is a characteristic signature of agostic bonding, [16] whereas the downfield shift of the  $\alpha$ -SiMe signal reflects the electron deficiency of cationic silvlium centers. The <sup>29</sup>Si NMR spectrum at -85°C, selectively decoupled from Me groups, reveals three signals, at  $\delta = 24.9$  (d,  $J_{H,Si} = 46.3 \text{ Hz}$ ), 15.3 (d,  $J_{H,Si} = 118.9 \text{ Hz}$ ), and -5.3 ppm (d,  $J_{\rm H.Si} = 170.7 \; {\rm Hz})^{[17]}$ , assigned to the Si atoms in the  $\alpha$ ,  $\beta$ , and  $\boldsymbol{\gamma}$  positions, respectively. The agostically stabilized silylium center gives rise to a downfield  $^{29}\text{Si NMR}$  signal ( $\delta$  = 24.9 ppm) which is close to the value found for the H-bridged cation **2** ( $\delta = 54.4$  ppm). <sup>[12b]</sup> The cation **4** is stable in CD<sub>2</sub>Cl<sub>2</sub> and CDCl<sub>3</sub> solutions at least for several days.

The H–Si coupling constants in **4** provide important information about the bonding situation in this compound. Thus, whereas the coupling constant associated with the  $\gamma$ -Si atom ( $J_{\rm H,Si^{\gamma}}$ ) of 170.7 Hz is close to the value expected for a free SiHMe<sub>2</sub> group, the highly decreased  $J_{\rm H,Si^{\alpha}}$  value of 46.3 Hz is indicative of a H-bridged silylium ion, a structural motif similar to that one reported for **1** ( $J_{\rm H,Si}$  = 39 Hz) and **2** ( $J_{\rm H,Si}$  = 45.7 Hz). The new prominent feature of **4** lies in the fact that the two half-charged cationic centers in the  $\alpha$  positions induce waning agostic interactions with the hydrides bound to the  $\beta$ -Si atoms, resulting in a noticeable decrease of the  $J_{\rm H,Si^{\beta}}$  value compared to the  $J_{\rm H,Si^{\gamma}}$  value (118.9

vs. 170.7 Hz). As a result of this additional  $Si^{\alpha} \leftarrow H - Si^{\beta}$  bonding, each equivalent silylium center adopts a distorted TBP (trigonal-bipyramidal) geometry with the hydride atoms in the apical positions (Figure 1).



**Figure 1.** a) DFT-calculated structure of agostically stabilized silylium ion **4.** b) DFT-calculated structure of agostically stabilized silylium ion **5.** Interatomic separations are given in Å.

Finally, the presence of agostic  $H^{\alpha}$  and  $H^{\beta}$  hydrides is clearly seen from the remarkable red shift of their Si–H bands in the IR spectrum (1725 cm<sup>-1</sup> (exptl) vs. 1655 cm<sup>-1</sup> (calcd) for Si–H $^{\alpha}$  and 1978 cm<sup>-1</sup> (exptl) vs. 1898 cm<sup>-1</sup> (calcd) for the symmetric stretch of two  $\beta$ -Si–H bonds<sup>[18]</sup>). In contrast, the  $\gamma$ -Si–H bonds give rise to a very broad band at about 2140 (exptl) versus 2134 and 2131 cm<sup>-1</sup> (calcd), in a region typical of hydrosilanes.

The room-temperature  $^1\text{H}$  NMR spectrum of **4** corresponds to an effective  $D_{6h}$  symmetry, giving rise to a SiH singlet at  $\delta = 4.60$  ppm and a SiMe singlet at  $\delta = 0.78$  ppm and indicative of fast exchange. This exchange most likely occurs through hydride transfer between the  $\alpha$  silicon centers, assisted by the agostic bonding with the  $\beta$ -Si-H bond.

The suggested H-bridged silylium ion structure supported by two  $Si^{\alpha} \leftarrow H - Si^{\beta}$  agostic interactions was further elucidated by DFT calculations (Figure 1a).<sup>[19]</sup> The optimized structure of **4** exhibits  $C_2$  symmetry. The bridging hydride forms two equivalent elongated Si-H bonds to the α-Si atoms with lengths of 1.686 Å and a Si-H-Si bond angle of 130.2°. If the Si–H bonding is neglected, the  $\alpha$ -silylium ion is almost planar (the sum of bond angles is 358.9°). A similar geometry (1.607 Å and 134.7°) has been calculated for 2 at the MP2/6-311G\*\* level. [12b] The agostic β-hydride forms an elongated bond to the β-Si center (1.558 Å vs. 1.4-1.5 Å in hydrosilanes), and a longer agostic bond to the  $\alpha$ -silylium ion (1.980 Å). For comparison, the "unperturbed" γ-Si-H bond was calculated to be 1.507 Å and the  $Si^{\beta}$ ... $H^{\gamma}$  separation (2.504 Å) is too long for a significant interaction. Calculation of the <sup>29</sup>Si NMR parameters using the GIAO method<sup>[19]</sup> gives  $\delta$  = 22.1, 28.2, and -3.8 ppm for the  $\alpha$ -,  $\beta$ -, and  $\gamma$ -Si atoms, respectively. A small  $J_{Si,H}$  value of -38.2 Hz was calculated for the bridging hydride, in fair agreement with the experimental value (|J| = 46.3 Hz). The  $\alpha$ -Si center is only weakly coupled with the agostic β-hydrogen atom ( $J_{Si,H} = -3.5 \text{ Hz}$ ), but the negative sign of  $J_{\mathrm{Si,H}}$  suggests direct bonding. [16] It is important to stress that this small absolute value of  $J_{\rm Si,H}$  is merely the result of the geometry of the ArSiαMe2 group rather than reflective of the weakness of agostic interaction. In fact, the ArSi^{\alpha}Me\_2 fragment is nearly planar, so that bonding to the hydride is primarily provided through the Si p orbital, resulting in severe reduction of the Fermi contact term. [12a,b] As noted above, the coupling constant between the  $\beta$ -Si and  $\beta$ -H atoms is decreased, (118.9 Hz (exptl) and -103.6 Hz (calcd)), which is the result of elongation of the Si–H bond and distortion of the C-Si $^{\beta}$ -H bond angle to 94.6° owing to agostic bonding (compare:  $101.2^{\circ}$  for the C-Si $^{\gamma}$ -H angle). Again, such a distortion leads to increased  $\beta$ -Si p character in the Si $^{\beta}$ -H $^{\beta}$  bond.

As expected, the 3c–2e  $\mathrm{Si}^{\alpha}$ -H $^{\alpha}$ -Si $^{\alpha}$  bond is characterized by larger Mayer bond orders (Si–H MBO = 0.445) and Wiberg bond orders (WBO = 0.426) than the "Si —HSi $^{\beta}$  agostic bonding (MBO = 0.242, WBO = 0.182; Table 1).<sup>[20]</sup> The natural bond orbital (NBO)<sup>[21]</sup> occupation of the H $^{\beta}$ -Si $^{\beta}$  bond (1.806) is reduced in comparison with the H $^{\gamma}$ -Si $^{\gamma}$  single bond

**Table 1:** Mayer bond orders, Wiberg bond orders, occupation of the H–Si natural bond orbital, and Mayer diatomic energies (MDE, in kcal mol<sup>-1</sup>).

Cmpd	Bond	<i>d</i> (Si−H) [Å]	МВО	WBO	H-Si NBO occupation <sup>[a]</sup>	MDE
4	$H^{\alpha}\text{-}Si^{\alpha}$	1.686	0.445	0.426	_	-94.4
	$H^{\beta} ext{-}Si^{lpha}$	1.980	0.242	0.182	_	-68.4
	$H^{\beta} ext{-}Si^{\beta}$	1.558	0.664	0.692	1.806	-116.0
	$H^\gamma ext{-}Si^eta$	2.504	0.104	0.034	_	-35.0
	$H^{\gamma}$ -Si $^{\gamma}$	1.508	0.828	0.880	1.938	-126.1
5	$H^{\beta} ext{-}Si^{lpha}$	1.820	0.325	0.286	_	-78.2
	$H^{\beta} ext{-}Si^{\beta}$	1.595	0.582	0.584	1.722	-105.9
	$H^\gamma ext{-}Si^eta$	2.515	0.114	0.041	_	-36.8
	$H^\gamma\text{-}Si^\gamma$	1.514	0.821	0.871	1.934	-122.2

[a] Missing data means that no NBO has been found.

(1.938) owing to electron-density transfer to the cationic  $S^{i\alpha}$  centers. Large attractive (that is, negative) values of Mayer diatomic energies<sup>[22]</sup> for the Si–H bond in **4** (right-hand column of Table 1) present strong evidence of significant Si···H interactions. Finally, bond critical points with negative energy density were found by using the AIM approach<sup>[23]</sup> both for  $S^{i\alpha}$ -H<sup> $\alpha$ </sup>-Si<sup> $\alpha$ </sup> and  $S^{i\alpha}$ -H-Si<sup> $\beta$ </sup> interactions (see TableSI1 in the Supporting Information).

Can we cut the "hydride current" in **4**? To do this, we introduced a "methyl insulator" in **4** by reacting the persilylated toluene derivative  $MeC_6(SiHMe_2)_5$  with  $[Ph_3C][B-(C_6F_5)_4]$  [Eq. (2)]. Contrarily to **4**, NMR spectra of the product of this reaction, the silylium ion  $[MeC_6(SiHMe_2)_4-(SiMe_2)]^+$  (5), are temperature-independent down to -80 °C. The room-temperature <sup>1</sup>H NMR spectrum of **5** shows two SiH

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signals, a septet at  $\delta = 4.53$  ( ${}^2J_{\rm H,H} = 3.6$  Hz) for the free  $Si^{\gamma}Me_{2}H$  group and an upfield-shifted singlet at  $\delta =$ 4.28 ppm for  $H^{\beta}$ , indicative of agostic bonding. The methyl groups give rise to three signals at  $\delta = 1.02$  (silylium ion  $SiMe_{2}^{\alpha}$ ), 0.84 (d,  ${}^{2}J_{HH} = 2.1$  Hz,  $Me^{\beta}$ ), and 0.54 ppm (d,  ${}^{2}J_{HH} =$ 3.6 Hz, Me<sup>y</sup>), with relative intensities of 1:2:2. Like 4, the cation 5 is stable in chlorinated solvents at least for two days. The <sup>29</sup>Si NMR spectrum of **5** contains three signals. The Si<sup>7</sup>Me<sub>2</sub>H group, which is not involved in significant agostic bonding, gives rise to a doublet of septets at  $\delta = -4.5$  ppm  $(^2J_{Si,H} = 7.1 \text{ Hz}, \ ^1J_{Si,H} = 166.2 \text{ Hz})$ . The two  $Si^{\beta}Me_2H$  groups, complexing the silylium ion through two Si-H agostic interactions, have a downfield-shifted (compared to the values expected for a PhSiMe<sub>2</sub>H moiety) signal at  $\delta =$ 33.5 ppm with a noticeably decreased direct Si-H coupling  $(^{1}J_{SiH} = 87.2 \text{ Hz}, ^{2}J_{SiH} = 6.9 \text{ Hz})$ . Finally, the silylium ion gives rise to a multiplet at  $\delta = 34.3$  ppm, which upon selective decoupling from the Me protons resolves into a triplet with  $^{1}J_{Si^{\alpha}H^{\beta}} = 16.1$  Hz, suggesting a diagostic bonding with the  $\beta$ -H-Si bonds. Cooling down the sample to -80 °C does not change these spectral patterns, apart from the expected temperatureinduced shifts of resonances, consistent with the absence of fluctionality in this system. The IR spectrum of 5 exhibits two red-shifted bands  $^{[16]}$  (1747 cm $^{-1}$  (exptl) vs. 1738 cm $^{-1}$  (calcd) and 1810 cm<sup>-1</sup> (exptl) vs. 1817 cm<sup>-1</sup> (calcd)) for the agostic  $Si^{\alpha}$ -H- $Si^{\beta}$  bonds and one merged band for the  $\gamma$ -Si-H bonds at  $2107 \text{ cm}^{-1}$  (2094–2098 cm<sup>-1</sup> (calcd)). To the best of our knowledge, such a diagostic bonding is unprecedented in the chemistry of silicon cations. The closest analogy exists only with the weak B-H...Sn interactions reported by Izod et al. for a stannylene compound. [24]

The DFT-calculated structure of 5 completely supports the presence of diagostic bonding (Figure 1b). A structure with approximate  $C_s$  symmetry was obtained as a result of optimization. The  $Si^{\alpha} \leftarrow H^{\beta}$ - $Si^{\beta}$  bonds (1.818 and 1.822 Å) in **5** are longer than the  $Si^{\alpha}$ - $H^{\alpha}$  bond in 4 but shorter than the  $Si^{\alpha} \leftarrow H^{\beta} - Si^{\beta}$  agostic interaction in **4**. The  $H^{\beta} - Si^{\beta}$  bond in **5** (1.594/1.596 Å) is elongated as a result of electron-density transfer to the silylium ion. The  $Si^{\beta}$  center exhibits the same distorted C-Si-H angle of 93.3° as the agostic  $Si^{\beta}$  center in 4. The calculated  $J_{Si,H}$  values are in fair accord with the absolute experimental coupling constants (|J| in parentheses):  $-14.8 \text{ Hz} (16.1 \text{ Hz}) \text{ for } H^{\beta}-\text{Si}^{\alpha}, -76.3 \text{ Hz} (87.2 \text{ Hz}) \text{ for } H^{\beta}-\text{Si}^{\alpha}$  $Si^{\beta},$  and -166.2~Hz (156.2 Hz) for  $^{\gamma}H^{-\gamma}Si.^{[25]}$  As in 4, the low values of  $J_{\mathrm{Si}^{\alpha}\mathrm{H}^{\beta}}$  and  $J_{\mathrm{Si}^{\beta}\mathrm{H}^{\beta}}$  are the result of a higher silicon p contribution to the Si-H bonding (NBO occupation of the "free" Si p orbital is 0.484, Table 1). The diagostic  $Si^{\beta}$ -H $\rightarrow$  $Si^{\alpha} \leftarrow H - Si^{\beta}$  interaction in 5 (MBO = 0.325) is weaker than the  $3c-2e Si^{\alpha}-H-Si^{\alpha}$  bond in 4 (MBO = 0.445) but stronger than its  $Si^{\alpha} \leftarrow H - Si^{\beta}$  agostic bonding (MBO = 0.242). Correspondingly, the  $H^{\beta}$ -Si<sup>\beta</sup> bond in **5** is weaker than the  $H^{\beta}$ -Si<sup>\beta</sup> bond in **4** (MBO = 0.582 and 0.664, respectively). Finally, the AIM study of **5** revealed bond critical points for both Si<sup>α</sup>←H-Si<sup>β</sup> interactions.

Although a pentacoordinate silicon anion with two apical hydride atoms has been recently characterized, <sup>[26]</sup> **4** and **5** present the first examples of a compound in which two Si–H bonds serve as ligands to a hypervalent silicon center. <sup>[27]</sup> Or, if

an alternative view is adopted, the structures **4** and **5** exhibit multiple agostic interactions induced by the silylium ion.

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- [17] Corresponds well to the value of 171 Hz measured from the left-hand part of the  $\gamma$ -HSi doublet in the  $^1$ H NMR spectrum. A  $^{29}$ Si INEPT+ NMR experiment at -80°C afforded the values 116.9 Hz and 171.2 Hz for  $J_{\rm H,Si}$ , respectively (see the Supporting Information).
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